

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination ERTEL ET AL.	
		Examiner Faye Boosalis	Art Unit 2884	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0094732	05-2004	Yonekawa, Hisashi	250/589
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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	N	JP2003014854	01-2003	Japan	Emoto Kengo	G01T 1/20
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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